

<b>Notice of References Cited</b>	Application/Control No. 10/781,523		Applicant(s)/Patent Under Reexamination SUNDARAM ET AL.	
	Examiner Jerome Jackson Jr.		Art Unit 2815	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,485,015	01-1996	Choi, Kwong-Kit	257/21
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tsai et al, IEEE Electron Device Letters, Vol. 16 No. 2, February 1995 "Two-Dimensional...Photodetectors" pp.49-51.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.